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Applications of Embedded - Microprocessors

Embedded microprocessors are utilized across a broad spectrum of applications, making them indispensable in

Details	
Product Status	Active
Core Processor	PowerPC G4
Number of Cores/Bus Width	1 Core, 32-Bit
Speed	1.0GHz
Co-Processors/DSP	Multimedia; SIMD
RAM Controllers	-
Graphics Acceleration	No
Display & Interface Controllers	-
Ethernet	-
SATA	-
USB	-
Voltage - I/O	1.5V, 1.8V, 2.5V
Operating Temperature	0°C ~ 105°C (TA)
Security Features	-
Package / Case	483-BCBGA, FCCBGA
Supplier Device Package	483-FCCBGA (29x29)
Purchase URL	https://www.e-xfl.com/pro/item?MUrl=&PartUrl=mc7457rx1000lc

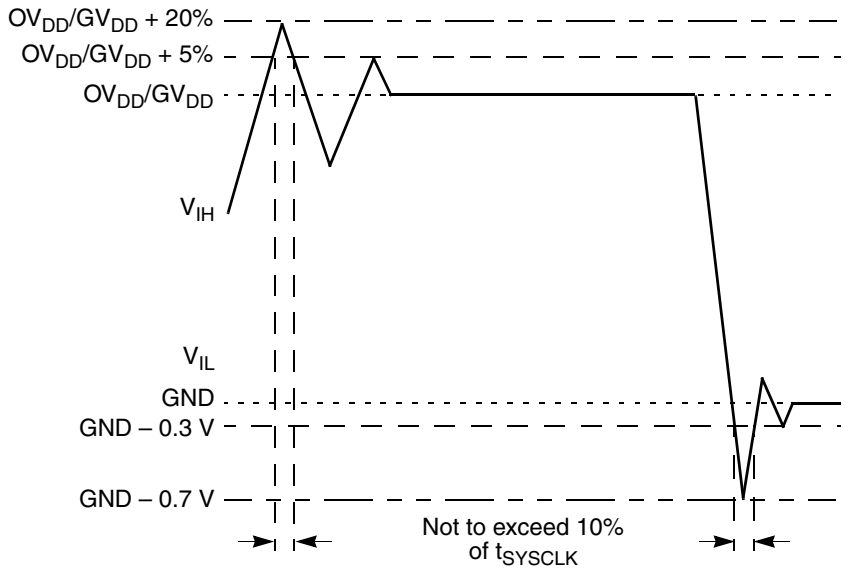


Figure 2. Overshoot/Undershoot Voltage

The MPC7457 provides several I/O voltages to support both compatibility with existing systems and migration to future systems. The MPC7457 core voltage must always be provided at nominal 1.3 V (see Table 4 for actual recommended core voltage). Voltage to the L3 I/Os and processor interface I/Os are provided through separate sets of supply pins and may be provided at the voltages shown in Table 3. The input voltage threshold for each bus is selected by sampling the state of the voltage select pins at the negation of the signal $\overline{\text{HRESET}}$. The output voltage will swing from GND to the maximum voltage applied to the OV_{DD} or GV_{DD} power pins.

Table 3. Input Threshold Voltage Setting

BVSEL Signal	Processor Bus Input Threshold is Relative to:	L3VSEL Signal [1]	L3 Bus Input Threshold is Relative to:	Notes
0	1.8 V	0	1.8 V	2, 3
¬$\overline{\text{HRESET}}$	Not Available	¬$\overline{\text{HRESET}}$	1.5 V	2, 4
$\overline{\text{HRESET}}$	2.5 V	$\overline{\text{HRESET}}$	2.5 V	2
1	2.5 V	1	2.5 V	2

Notes:

1. Not implemented on MPC7447.
2. **Caution:** The input threshold selection must agree with the OV_{DD}/GV_{DD} voltages supplied. See notes in Table 2.
3. If used, pull-down resistors should be less than 250 Ω.
4. Applicable to L3 bus interface only. ¬$\overline{\text{HRESET}}$ is the inverse of $\overline{\text{HRESET}}$.

Table 13. L3 Bus Interface AC Timing Specifications for MSUG2 (continued)

At recommended operating conditions. See Table 4.

Parameter	Symbol	Device Revision (L3 I/O Voltage) [9]				Unit	Notes
		Rev 1.1. (All I/O Modes) Rev 1.2 (1.5-V I/O Mode)		Rev 1.2 (1.8-, 2.5-V I/O Modes)			
		Min	Max	Min	Max		
L3_CLK to high impedance: All other outputs	t_{L3CHOZ}	—	(t_{L3CLK}/4) + 0.65	—	(t_{L3CLK}/4) + 0.65	ns	

Notes:

1. Rise and fall times for the L3_CLK output are measured from 20% to 80% of GV_{DD}.
2. For DDR, all input specifications are measured from the midpoint of the signal in question to the midpoint voltage of the rising or falling edge of the input L3_ECHO_CLK*n* (see Figure 10). Input timings are measured at the pins.
3. For DDR, the input data will typically follow the edge of L3_ECHO_CLK*n* as shown in Figure 10. For consistency with other input setup time specifications, this will be treated as negative input setup time.
4. t_{L3_CLK}/4 is one-fourth the period of L3_CLK*n*. This parameter indicates that the MPC7457 can latch an input signal that is valid for only a short time before and a short time after the midpoint between the rising and falling (or falling and rising) edges of L3_ECHO_CLK*n* at any frequency.
5. All output specifications are measured from the midpoint voltage of the rising (or for DDR write data, also the falling) edge of L3_CLK to the midpoint of the signal in question. The output timings are measured at the pins. All output timings assume a purely resistive 50-Ω load (see Figure 8).
6. For DDR, the output data will typically lead the edge of L3_CLK*n* as shown in Figure 10. For consistency with other output valid time specifications, this will be treated as negative output valid time.
7. t_{L3_CLK}/4 is one-fourth the period of L3_CLK*n*. This parameter indicates that the specified output signal is actually launched by an internal clock delayed in phase by 90°. Therefore, there is a frequency component to the output valid and output hold times such that the specified output signal will be valid for approximately one L3_CLK period starting three-fourths of a clock before the edge on which the SRAM will sample it and ending one-fourth of a clock period after the edge it will be sampled.
8. Assumes default value of L3OHCR. See Section 5.2.4.1, “Effects of L3OHCR Settings on L3 Bus AC Specifications,” for more information.
9. L3 I/O voltage mode must be configured by L3VSEL as described in Table 3, and voltage supplied at GV_{DD} must match mode selected as specified in Table 4. See Table 22 for revision level information and part marking.

Table 15. JTAG AC Timing Specifications (Independent of SYSCLK) [1] (continued)

At recommended operating conditions. See Table 4.

Parameter	Symbol	Min	Max	Unit	Notes
Valid times: Boundary-scan data TDO	 t_{JLDV} t_{JLOV}	 4 4	 20 25	ns	4
Output hold times: Boundary-scan data TDO	 t_{JLDX} t_{JLOX}	 30 30	 — —	ns	4
TCK to output high impedance: Boundary-scan data TDO	 t_{JLDZ} t_{JLOZ}	 3 3	 19 9	ns	4, 5

Notes:
1. All outputs are measured from the midpoint voltage of the falling/rising edge of TCLK to the midpoint of the signal in question. The output timings are measured at the pins. All output timings assume a purely resistive 50-Ω load (see Figure 13). Time-of-flight delays must be added for trace lengths, vias, and connectors in the system.
2. $\overline{\text{TRST}}$ is an asynchronous level sensitive signal. The setup time is for test purposes only.
3. Non-JTAG signal input timing with respect to TCK.
4. Non-JTAG signal output timing with respect to TCK.
5. Guaranteed by design and characterization.

Figure 13 provides the AC test load for TDO and the boundary-scan outputs of the MPC7457.

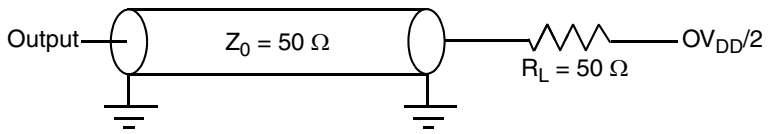


Figure 13. Alternate AC Test Load for the JTAG Interface

Figure 14 provides the JTAG clock input timing diagram.

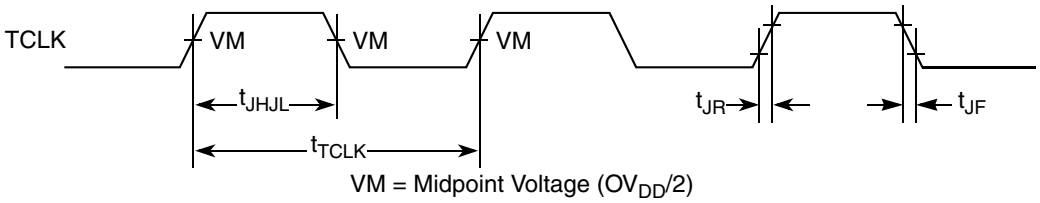


Figure 14. JTAG Clock Input Timing Diagram

Figure 15 provides the $\overline{\text{TRST}}$ timing diagram.

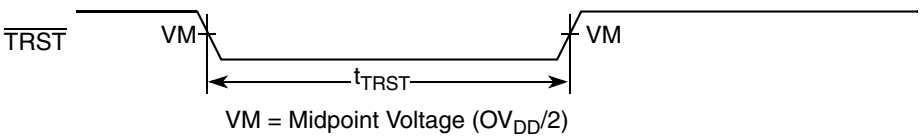
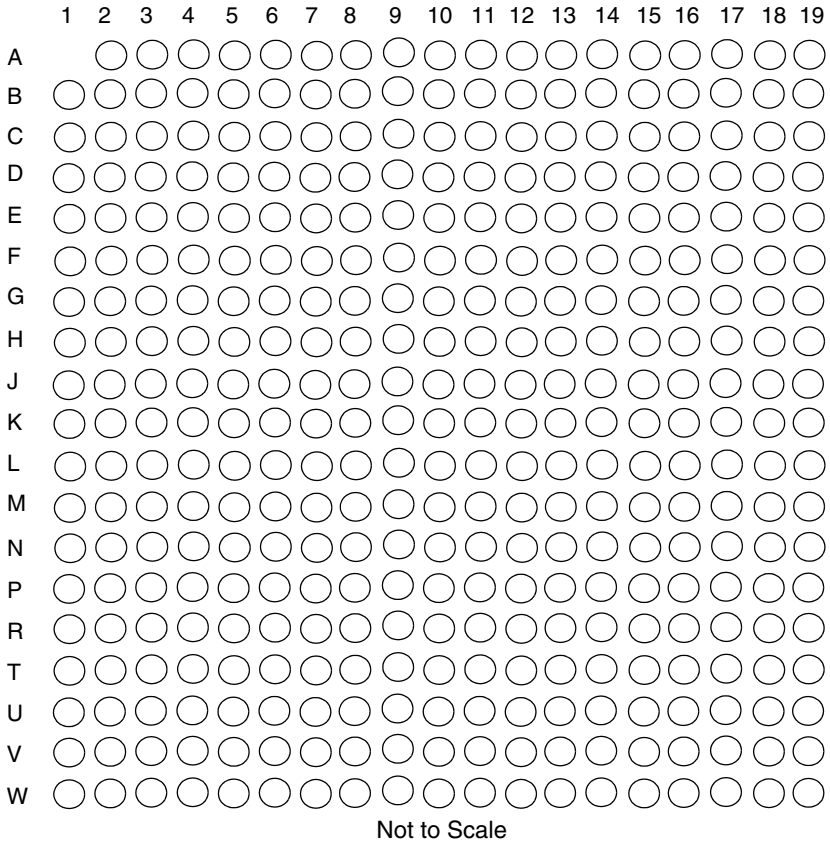


Figure 15. $\overline{\text{TRST}}$ Timing Diagram

6 Pin Assignments

Figure 18 (Part A) shows the pinout of the MPC7447, 360 CBGA package as viewed from the top surface. Part B shows the side profile of the CBGA package to indicate the direction of the top surface view.

Part A



Part B

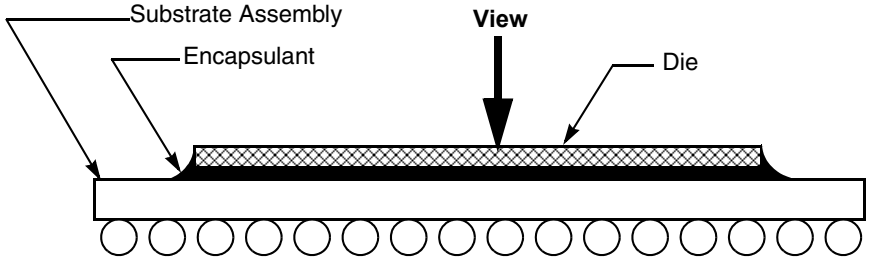
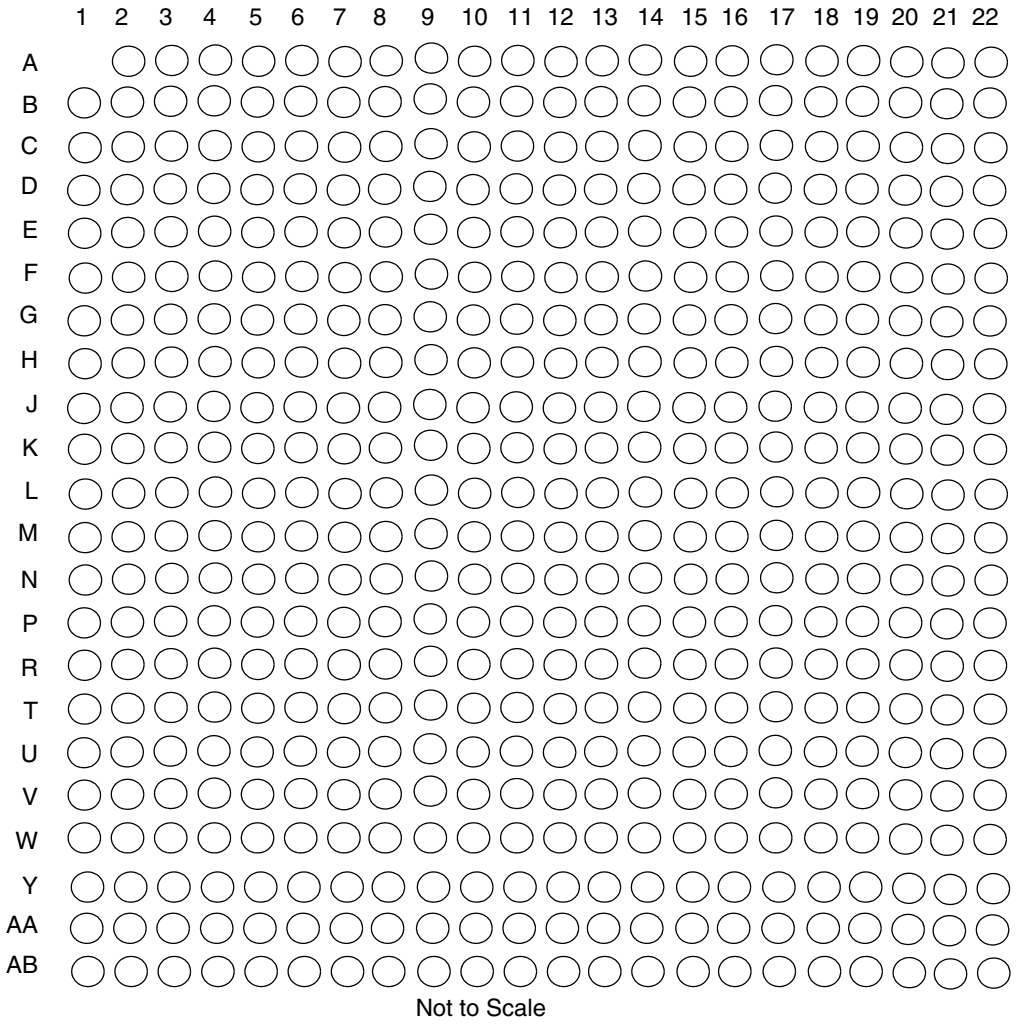


Figure 18. Pinout of the MPC7447, 360 CBGA Package as Viewed from the Top Surface

Figure 19 (Part A) shows the pinout of the MPC7457, 483 CBGA package as viewed from the top surface. Part B shows the side profile of the CBGA package to indicate the direction of the top surface view.

Part A



Part B

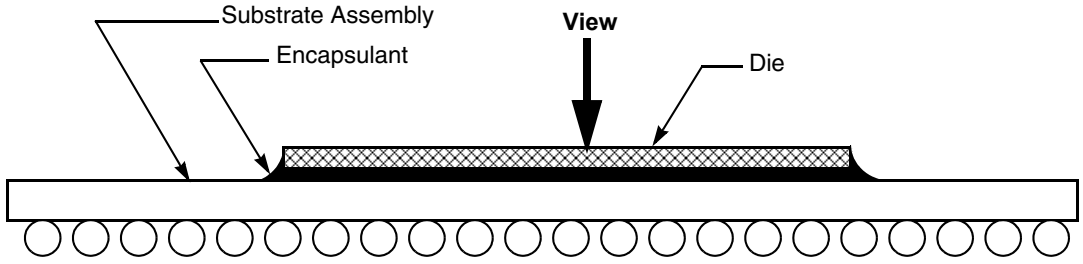


Figure 19. Pinout of the MPC7457, 483 CBGA Package as Viewed from the Top Surface

7 Pinout Listings

Table 16 provides the pinout listing for the MPC7447, 360 CBGA package. Table 17 provides the pinout listing for the MPC7457, 483 CBGA package.

NOTE

This pinout is not compatible with the MPC750, MPC7400, or MPC7410 360 BGA package.

Table 16. Pinout Listing for the MPC7447, 360 CBGA Package

Signal Name	Pin Number	Active	I/O	I/F Select [1]	Notes
A[0:35]	E11, H1, C11, G3, F10, L2, D11, D1, C10, G2, D12, L3, G4, T2, F4, V1, J4, R2, K5, W2, J2, K4, N4, J3, M5, P5, N3, T1, V2, U1, N5, W1, B12, C4, G10, B11	High	I/O	BVSEL	2
$\overline{\text{AACK}}$	R1	Low	Input	BVSEL	
AP[0:4]	C1, E3, H6, F5, G7	High	I/O	BVSEL	
$\overline{\text{ARTRY}}$	N2	Low	I/O	BVSEL	3
AV_{DD}	A8	—	Input	N/A	
$\overline{\text{BG}}$	M1	Low	Input	BVSEL	
$\overline{\text{BMODE0}}$	G9	Low	Input	BVSEL	4
$\overline{\text{BMODE1}}$	F8	Low	Input	BVSEL	5
$\overline{\text{BR}}$	D2	Low	Output	BVSEL	
BVSEL	B7	High	Input	BVSEL	1, 6
$\overline{\text{CI}}$	J1	Low	Output	BVSEL	
$\overline{\text{CKSTP\_IN}}$	A3	Low	Input	BVSEL	
$\overline{\text{CKSTP\_OUT}}$	B1	Low	Output	BVSEL	
CLK_OUT	H2	High	Output	BVSEL	
D[0:63]	R15, W15, T14, V16, W16, T15, U15, P14, V13, W13, T13, P13, U14, W14, R12, T12, W12, V12, N11, N10, R11, U11, W11, T11, R10, N9, P10, U10, R9, W10, U9, V9, W5, U6, T5, U5, W7, R6, P7, V6, P17, R19, V18, R18, V19, T19, U19, W19, U18, W17, W18, T16, T18, T17, W3, V17, U4, U8, U7, R7, P6, R8, W8, T8	High	I/O	BVSEL	
$\overline{\text{DBG}}$	M2	Low	Input	BVSEL	
DP[0:7]	T3, W4, T4, W9, M6, V3, N8, W6	High	I/O	BVSEL	
$\overline{\text{DRDY}}$	R3	Low	Output	BVSEL	7
DTI[0:3]	G1, K1, P1, N1	High	Input	BVSEL	8
EXT_QUAL	A11	High	Input	BVSEL	9
$\overline{\text{GBL}}$	E2	Low	I/O	BVSEL	

Table 16. Pinout Listing for the MPC7447, 360 CBGA Package (continued)

Signal Name	Pin Number	Active	I/O	I/F Select [1]	Notes
GND	B5, C3, D6, D13, E17, F3, G17, H4, H7, H9, H11, H13, J6, J8, J10, J12, K7, K3, K9, K11, K13, L6, L8, L10, L12, M4, M7, M9, M11, M13, N7, P3, P9, P12, R5, R14, R17, T7, T10, U3, U13, U17, V5, V8, V11, V15	—	—	N/A	
$\overline{\text{HIT}}$	B2	Low	Output	BVSEL	7
$\overline{\text{HRESET}}$	D8	Low	Input	BVSEL	
$\overline{\text{INT}}$	D4	Low	Input	BVSEL	
L1_TSTCLK	G8	High	Input	BVSEL	9
L2_TSTCLK	B3	High	Input	BVSEL	10
No Connect	A6, A13, A14, A15, A16, A17, A18, A19, B13, B14, B15, B16, B17, B18, B19, C13, C14, C15, C16, C17, C18, C19, D14, D15, D16, D17, D18, D19, E12, E13, E14, E15, E16, E19, F12, F13, F14, F15, F16, F17, F18, F19, G11, G12, G13, G14, G15, G16, G19, H14, H15, H16, H17, H18, H19, J14, J15, J16, J17, J18, J19, K15, K16, K17, K18, K19, L14, L15, L16, L17, L18, L19, M14, M15, M16, M17, M18, M19, N12, N13, N14, N15, N16, N17, N18, N19, P15, P16, P18, P19	—	—	—	11
$\overline{\text{LSSD\_MODE}}$	E8	Low	Input	BVSEL	6, 12
$\overline{\text{MCP}}$	C9	Low	Input	BVSEL	
OV_{DD}	B4, C2, C12, D5, E18, F2, G18, H3, J5, K2, L5, M3, N6, P2, P8, P11, R4, R13, R16, T6, T9, U2, U12, U16, V4, V7, V10, V14	—	—	N/A	
PLL_CFG[0:4]	B8, C8, C7, D7, A7	High	Input	BVSEL	
$\overline{\text{PMON\_IN}}$	D9	Low	Input	BVSEL	13
$\overline{\text{PMON\_OUT}}$	A9	Low	Output	BVSEL	
$\overline{\text{QACK}}$	G5	Low	Input	BVSEL	
$\overline{\text{QREQ}}$	P4	Low	Output	BVSEL	
$\overline{\text{SHD}}$[0:1]	E4, H5	Low	I/O	BVSEL	3
$\overline{\text{SMI}}$	F9	Low	Input	BVSEL	
$\overline{\text{SRESET}}$	A2	Low	Input	BVSEL	
SYSCLK	A10	—	Input	BVSEL	
$\overline{\text{TA}}$	K6	Low	Input	BVSEL	
TBEN	E1	High	Input	BVSEL	
$\overline{\text{TBST}}$	F11	Low	Output	BVSEL	
TCK	C6	High	Input	BVSEL	
TDI	B9	High	Input	BVSEL	6
TDO	A4	High	Output	BVSEL	

Table 17. Pinout Listing for the MPC7457, 483 CBGA Package (continued)

Signal Name	Pin Number	Active	I/O	I/F Select [1]	Notes
TDI	E4	High	Input	BVSEL	7
TDO	H1	High	Output	BVSEL	
$\overline{\text{TEA}}$	T1	Low	Input	BVSEL	
TEST[0:5]	B10, H6, H10, D8, F9, F8	—	Input	BVSEL	13
TEST[6]	A9	—	Input	BVSEL	10
TMS	K4	High	Input	BVSEL	7
$\overline{\text{TRST}}$	C1	Low	Input	BVSEL	7, 16
$\overline{\text{TS}}$	P5	Low	I/O	BVSEL	3
TSIZ[0:2]	L1,H3,D1	High	Output	BVSEL	
TT[0:4]	F1, F4, K8, A5, E1	High	I/O	BVSEL	
$\overline{\text{WT}}$	L2	Low	Output	BVSEL	
V_{DD}	J9, J11, J13, J15, K10, K12, K14, L9, L11, L13, L15, M10, M12, M14, N9, N11, N13, N15, P10, P12, P14	—	—	N/A	
VDD_SENSE[0:1]	G11, J8	—	—	N/A	17

Notes:

1. OV_{DD} supplies power to the processor bus, JTAG, and all control signals except the L3 cache controls (L3CTL[0:1]); GV_{DD} supplies power to the L3 cache interface (L3ADDR[0:17], L3DATA[0:63], L3DP[0:7], L3_ECHO_CLK[0:3], and L3_CLK[0:1]) and the L3 control signals $\overline{\text{L3\_CNTL}}$[0:1]; and V_{DD} supplies power to the processor core and the PLL (after filtering to become AV_{DD}). For actual recommended value of V_{in} or supply voltages, see Table 4.
2. Unused address pins must be pulled down to GND.
3. These pins require weak pull-up resistors (for example, 4.7 kΩ) to maintain the control signals in the negated state after they have been actively negated and released by the MPC7457 and other bus masters.
4. This signal selects between MPX bus mode (asserted) and 60x bus mode (negated) and will be sampled at $\overline{\text{HRESET}}$ going high.
5. This signal must be negated during reset, by pull up to OV_{DD} or negation by ¬$\overline{\text{HRESET}}$ (inverse of $\overline{\text{HRESET}}$), to ensure proper operation.
6. See Table 3 for bus voltage configuration information. If used, pull-down resistors should be less than 250 Ω.
7. Internal pull up on die.
8. Ignored in 60x bus mode.
9. These signals must be pulled down to GND if unused or if the MPC7457 is in 60x bus mode.
10. These input signals for factory use only and must be pulled down to GND for normal machine operation.
11. Power must be supplied to GV_{DD}, even when the L3 interface is disabled or unused.
12. This test signal is recommended to be tied to $\overline{\text{HRESET}}$; however, other configurations will not adversely affect performance.
13. These input signals are for factory use only and must be pulled up to OV_{DD} for normal machine operation.
14. These signals are for factory use only and must be left unconnected for normal machine operation.
15. This pin can externally cause a performance monitor event. Counting of the event is enabled via software.
16. This signal must be asserted during reset, by pull down to GND or assertion by $\overline{\text{HRESET}}$, to ensure proper operation.
17. These pins are internally connected to V_{DD}. They are intended to allow an external device to detect the core voltage level present at the processor core. If unused, they must be connected directly to V_{DD} or left unconnected.

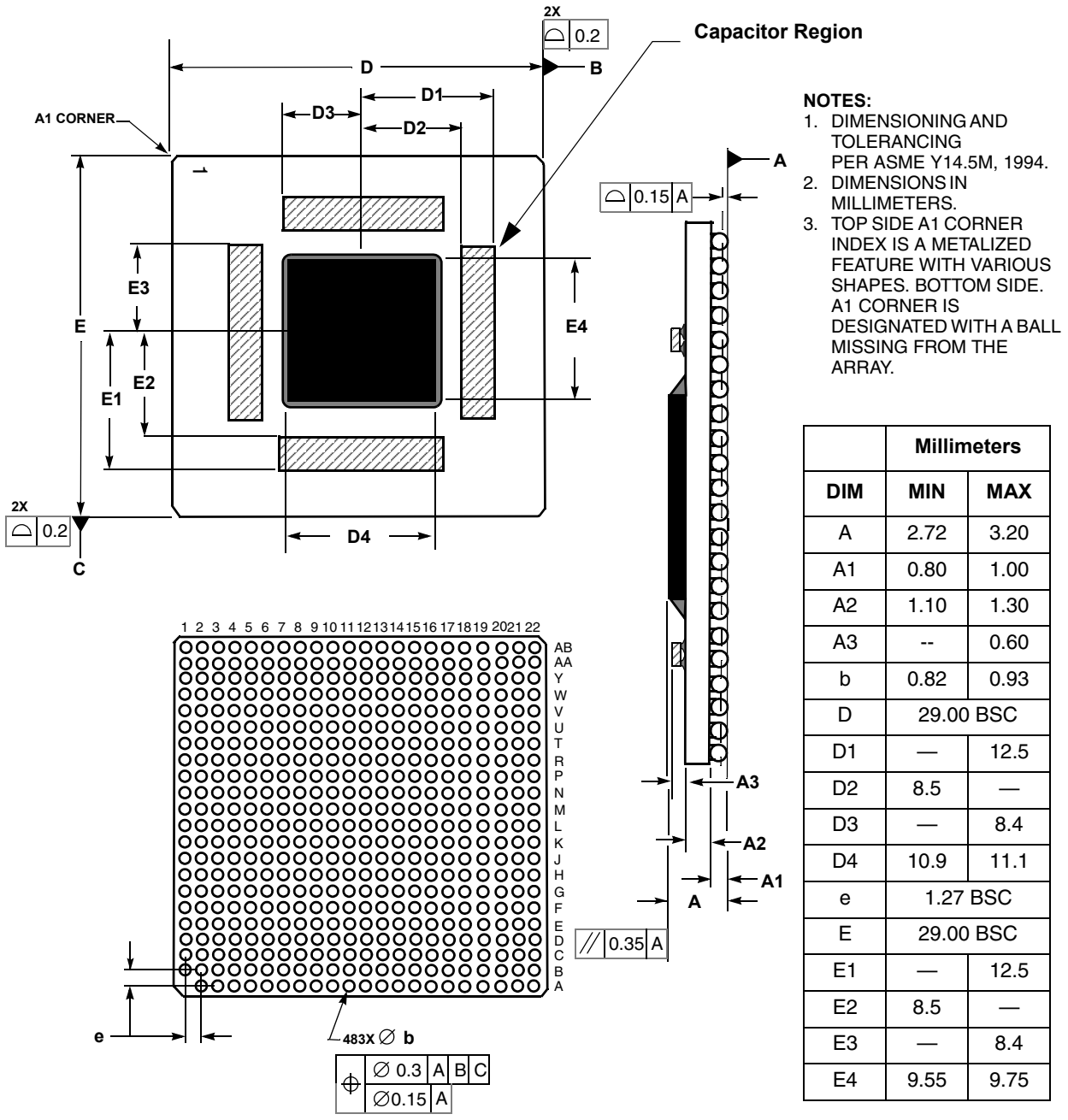
8.4 Package Parameters for the MPC7457, 483 CBGA or RoHS BGA

The package parameters are as provided in the following list. The package type is 29 × 29 mm, 483 ceramic ball grid array (CBGA).

Package outline	29 × 29 mm
Interconnects	483 (22 × 22 ball array – 1)
Pitch	1.27 mm (50 mil)
Minimum module height	—
Maximum module height	3.22 mm
Ball diameter	0.89 mm (35 mil)

8.5 Mechanical Dimensions for the MPC7457, 483 CBGA or RoHS BGA

Figure 22 provides the mechanical dimensions and bottom surface nomenclature for the MPC7457, 483 CBGA package.



NOTES:
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. DIMENSIONS IN MILLIMETERS.
3. TOP SIDE A1 CORNER INDEX IS A METALIZED FEATURE WITH VARIOUS SHAPES. BOTTOM SIDE. A1 CORNER IS DESIGNATED WITH A BALL MISSING FROM THE ARRAY.

	Millimeters	
DIM	MIN	MAX
A	2.72	3.20
A1	0.80	1.00
A2	1.10	1.30
A3	--	0.60
b	0.82	0.93
D	29.00 BSC	
D1	—	12.5
D2	8.5	—
D3	—	8.4
D4	10.9	11.1
e	1.27 BSC	
E	29.00 BSC	
E1	—	12.5
E2	8.5	—
E3	—	8.4
E4	9.55	9.75

Figure 22. Mechanical Dimensions and Bottom Surface Nomenclature for the MPC7457, 483 CBGA or RoHS BGA Package

Table 18. MPC7457 Microprocessor PLL Configuration Example for 1267 MHz Parts (continued)

PLL_CFG[0:4]	Bus-to-Core Multiplier	Core-to-VCO Multiplier	Example Bus-to-Core Frequency in MHz (VCO Frequency in MHz)							
			Bus (SYSCLK) Frequency							
			33.3 MHz	50 MHz	66.6 MHz	75 MHz	83 MHz	100 MHz	133 MHz	167 MHz
01111	9x	2x			600 (1200)	675 (1350)	747 (1494)	900 (1800)	1197 (2394)	
01110	9.5x	2x			633 (1266)	712 (1524)	789 (1578)	950 (1900)	1264 (2528)	
10101	10x	2x			667 (1333)	750 (1500)	830 (1660)	1000 (2000)		
10001	10.5x	2x			700 (1400)	938 (1876)	872 (1744)	1050 (2100)		
10011	11x	2x			733 (1466)	825 (1650)	913 (1826)	1100 (2200)		
00000	11.5x	2x			766 (532)	863 (1726)	955 (1910)	1150 (2300)		
10111	12x	2x		600 (1200)	800 (1600)	900 (1800)	996 (1992)	1200 (2400)		
11111	12.5x	2x		600 (1200)	833 (1666)	938 (1876)	1038 (2076)	1250 (2500)		
01011	13x	2x		650 (1300)	865 (1730)	975 (1950)	1079 (2158)			
11100	13.5x	2x		675 (1350)	900 (1800)	1013 (2026)	1121 (2242)			
11001	14x	2x		700 (1400)	933 (1866)	1050 (2100)	1162 (2324)			
00011	15x	2x		750 (1500)	1000 (2000)	1125 (2250)	1245 (2490)			
11011	16x	2x		800 (1600)	1066 (2132)	1200 (2400)				
00001	17x	2x		850 (1900)	1132 (2264)					
00101	18x	2x	600 (1200)	900 (1800)	1200 (2400)					
00111	20x	2x	667 (1334)	1000 (2000)						
01001	21x	2x	700 (1400)	1050 (2100)						
01101	24x	2x	800 (1600)	1200 (2400)						
11101	28x	2x	933 (1866)							
00110	PLL bypass		PLL off, SYSCLK clocks core circuitry directly							

Table 19. Sample Core-to-L3 Frequencies [1] (continued)

Core Frequency (MHz) [2]	÷2	÷2.5	÷3	÷3.5	÷4	÷4.5	÷5	÷5.5	÷6	÷6.5	÷7	÷7.5	÷8
1050	525	420	350	300	263	233	191	191	175	162	150	140	131
1100	550	440	367	314	275	244	200	200	183	169	157	147	138
1150	575	460	383	329	288	256	209	209	192	177	164	153	144
1200	600	480	400	343	300	267	218	218	200	185	171	160	150
1250	638	500	417	357	313	278	227	227	208	192	179	167	156
1300	650	520	433	371	325	289	236	236	217	200	186	173	163

Notes:
1. The core and L3 frequencies are for reference only. Note that maximum L3 frequency is design dependent. Some examples may represent core or L3 frequencies which are not useful, not supported, or not tested for the MPC7457; see Section 5.2.3, "L3 Clock AC Specifications," for valid L3_CLK frequencies and for more information regarding the maximum L3 frequency.
2. Not all core frequencies are supported by all speed grades; see Table 8 for minimum and maximum core frequency specifications.

9.1.3 System Bus Clock (SYSCLK) and Spread Spectrum Sources

Spread spectrum clock sources are an increasingly popular way to control electromagnetic interference emissions (EMI) by spreading the emitted noise to a wider spectrum and reducing the peak noise magnitude in order to meet industry and government requirements. These clock sources intentionally add long-term jitter in order to diffuse the EMI spectral content. The jitter specification given in Table 8 considers short-term (cycle-to-cycle) jitter only and the clock generator's cycle-to-cycle output jitter should meet the MPC7457 input cycle-to-cycle jitter requirement. Frequency modulation and spread are separate concerns, and the MPC7457 is compatible with spread spectrum sources if the recommendations listed in Table 20 are observed.

Table 20. Spread Specturm Clock Source Recommendations

At recommended operating conditions. See Table 4.

Parameter	Min	Max	Unit	Notes
Frequency modulation	—	50	kHz	1
Frequency spread	—	1.0	%	1, 2

Notes:
1. Guaranteed by design.
2. SYSCLK frequencies resulting from frequency spreading, and the resulting core and VCO frequencies, must meet the minimum and maximum specifications given in Table 8.

It is imperative to note that the processor's minimum and maximum SYSCLK, core, and VCO frequencies must not be exceeded regardless of the type of clock source. Therefore, systems in which the processor is operated at its maximum rated core or bus frequency should avoid violating the stated limits by using down-spreading only.

The $\overline{\text{QACK}}$ signal shown in Figure 26 is usually connected to the PCI bridge chip in a system and is an input to the MPC7457 informing it that it can go into the quiescent state. Under normal operation this occurs during a low-power mode selection. In order for COP to work, the MPC7457 must see this signal asserted (pulled down). While shown on the COP header, not all emulator products drive this signal. If the product does not, a pull-down resistor can be populated to assert this signal. Additionally, some emulator products implement open-drain type outputs and can only drive $\overline{\text{QACK}}$ asserted; for these tools, a pull-up resistor can be implemented to ensure this signal is deasserted when it is not being driven by the tool. Note that the pull-up and pull-down resistors on the $\overline{\text{QACK}}$ signal are mutually exclusive and it is never necessary to populate both in a system. To preserve correct power-down operation, $\overline{\text{QACK}}$ should be merged via logic so that it also can be driven by the PCI bridge.

9.8.2 Thermal Interface Materials

A thermal interface material is recommended at the package lid-to-heat sink interface to minimize the thermal contact resistance. For those applications where the heat sink is attached by spring clip mechanism, Figure 29 shows the thermal performance of three thin-sheet thermal-interface materials (silicone, graphite/oil, floroether oil), a bare joint, and a joint with thermal grease as a function of contact pressure. As shown, the performance of these thermal interface materials improves with increasing contact pressure. The use of thermal grease significantly reduces the interface thermal resistance. That is, the bare joint results in a thermal resistance approximately seven times greater than the thermal grease joint.

Often, heat sinks are attached to the package by means of a spring clip to holes in the printed-circuit board (see Figure 27). Therefore, the synthetic grease offers the best thermal performance, considering the low interface pressure and is recommended due to the high power dissipation of the MPC7457. Of course, the selection of any thermal interface material depends on many factors—thermal performance requirements, manufacturability, service temperature, dielectric properties, cost, etc.

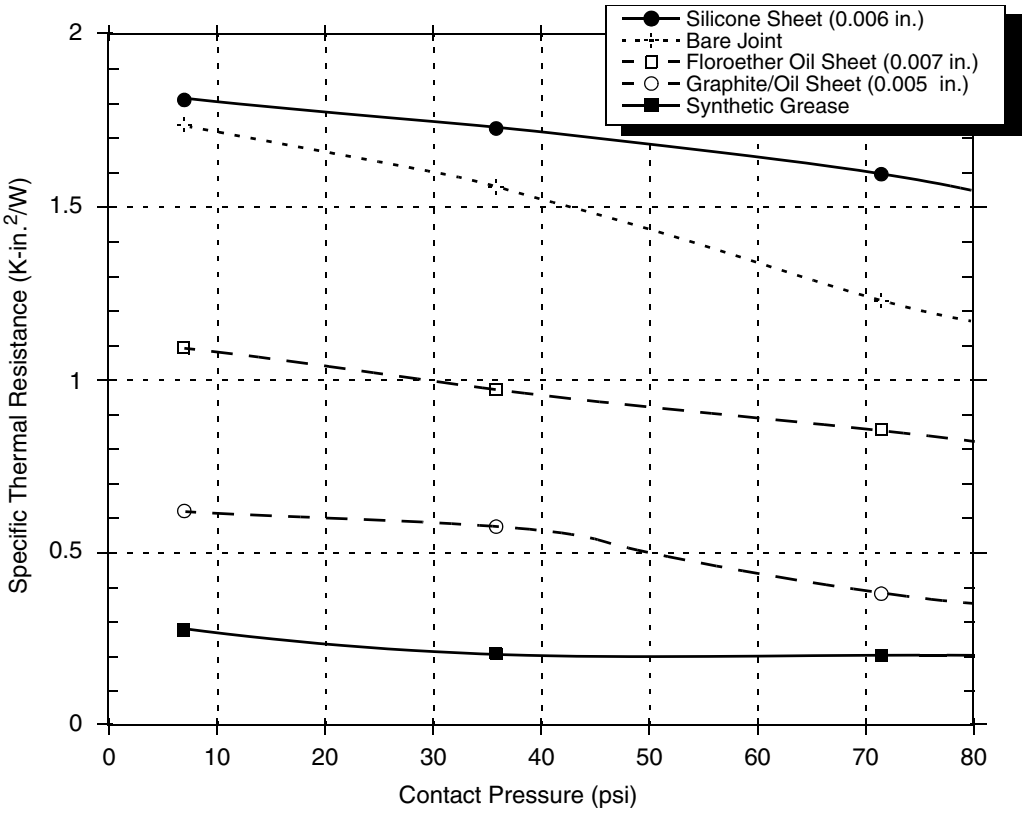


Figure 29. Thermal Performance of Select Thermal Interface Material

The board designer can choose between several types of thermal interface. Heat sink adhesive materials should be selected based on high conductivity, yet adequate mechanical strength to meet equipment shock/vibration requirements. There are several commercially available thermal interfaces and adhesive materials provided by the following vendors:

The Bergquist Company 18930 West 78th St. Chanhassen, MN 55317 Internet: www.bergquistcompany.com	800-347-4572
Chomerics, Inc. 77 Dragon Ct. Woburn, MA 01888-4014 Internet: www.chomerics.com	781-935-4850
Dow-Corning Corporation Dow-Corning Electronic Materials 2200 W. Salzburg Rd. Midland, MI 48686-0997 Internet: www.dow.com	800-248-2481
Shin-Etsu MicroSi, Inc. 10028 S. 51st St. Phoenix, AZ 85044 Internet: www.microsi.com	888-642-7674
Thermagon Inc. 4707 Detroit Ave. Cleveland, OH 44102 Internet: www.thermagon.com	888-246-9050

The following section provides a heat sink selection example using one of the commercially available heat sinks.

9.8.3 Heat Sink Selection Example

For preliminary heat sink sizing, the die-junction temperature can be expressed as follows:

$$T_j = T_I + T_r + (R_{\theta JC} + R_{\theta int} + R_{\theta sa}) \times P_d$$

where:

T_j is the die-junction temperature

T_I is the inlet cabinet ambient temperature

T_r is the air temperature rise within the computer cabinet

$R_{\theta JC}$ is the junction-to-case thermal resistance

$R_{\theta int}$ is the adhesive or interface material thermal resistance

$R_{\theta sa}$ is the heat sink base-to-ambient thermal resistance

P_d is the power dissipated by the device

During operation, the die-junction temperatures (T_j) should be maintained less than the value specified in Table 4. The temperature of air cooling the component greatly depends on the ambient inlet air temperature and the air temperature rise within the electronic cabinet. An electronic cabinet inlet-air temperature (T_a) may range from 30° to 40°C. The air temperature rise within a cabinet (T_r) may be in the range of 5° to 10°C. The thermal resistance of the thermal interface material ($R_{\theta int}$) is typically about 1.5°C/W. For

Table 22. Part Numbering Nomenclature

MC	74*x*7	*xx*	*nnnn*	L	*x*

Product Code	Part Identifier	Package	Processor Frequency [1]	Application Modifier	Revision Level
PPC [2] MC	7457 7447	RX = CBGA	867 1000 1200 1267	L: 1.3 V ± 50 mV 0° to 105°C	B: 1.1; PVR = 8002 0101
MC	7457	RX = CBGA VG = RoHS BGA	867 1000 1200 1267		C: 1.2; PVR = 8002 0102

Notes:

1. Processor core frequencies supported by parts addressed by this specification only. Parts addressed by a hardware specification addendum may support other maximum core frequencies.
2. The P prefix in a Freescale part number designates a “Pilot Production Prototype” as defined by Freescale SOP 3-13. These parts have only preliminary reliability and characterization data. Before pilot production prototypes may be shipped, written authorization from the customer must be on file in the applicable sales office acknowledging the qualification status and the fact that product changes may still occur while shipping pilot production prototypes.

10.2 Part Numbers Not Fully Addressed by This Document

Parts with application modifiers or revision levels not fully addressed are described in a separate addendum, which supplement and supersede this hardware specification. As such parts are released, these specifications will be listed in this section.

Table 23. Part Numbers Addressed by MPC74x7RX*nnnn*N*x* Series Hardware Specifications Addendum (Document Order No. MPC7457ECS01AD)

MC	74*x*7	*xx*	*nnnn*	N	*x*

Product Code	Part Identifier	Package	Processor Frequency	Application Modifier	Revision Level
PPC	7457	RX = CBGA	1000 867 733 600	N: 1.1 V ± 50 mV 0° to 105°C	B: 1.1; PVR = 8002 0101
	7447		1000 867		
MC	7447		1000 867 733 600		B: 1.1; PVR = 8002 0101
	7457	RX = CBGA VG = RoHS BGA	1000 867 733 600		C: 1.2; PVR = 8002 0102

11 Document Revision History

Table 26 provides a revision history for this hardware specification.

Table 26. Document Revision History

Revision Number	Date	Substantive Change(s)
8	04/09/2013	Updated template. Updated Table 14 “L3 Bus Interface AC Timing Specifications for PB2 and Late Write SRAMs”. Moved Revision History to the end of the document.
7	3/28/2006	Updated template. Section 2, reworded L1 and L2 cache descriptions. Removed note references for $\overline{CI}$ and $\overline{WT}$ in Table 12. Added VG package signifier for 7457 only.
6	7/22/2005	Revised Note in Section 9.2.
		Added heat sink vendor to list in Section 9.8.
		Corrected bump and underfill model dimension in Section 9.8.3.
5	9/9/2004	Updated document to new Freescale template.
		Updated section numbering and changed reference from part number specifications to addendums.
		Added Rev. 1.2 devices, including increased L3 clock max frequency to 250 MHz and improved L3 AC timing.
		Table 5: Added CTE information.
		Table 8: Modified jitter specifications to conform to JEDEC standards, changed jitter specification to cycle-to-cycle jitter (instead of long- and short-term jitter); changed jitter bandwidth recommendations.
		Table 13: Deleted note 9 and renumbered.
		Table 14: Deleted note 5 and renumbered.
		Table 17: Revised note 6.
		Added Section 9.1.3.
		Section 9.2: Changed filter resistor recommendations. Recommend 10 Ω resistor for all production devices, including production Rev. 1.1 devices. 400 Ω resistor needed only for early Rev. 1.1 devices.
		Table 22: Reversed the order of revision numbers.
		Added Tables 25 and 26.
4.1		Section 9.1.1: Corrected note regarding different PLL configurations for earlier devices; all MPC7457 devices to date conform to this table.
		Section 9.6: Added information about unused L3_ADDR signals.
		Table 24: Changed title to include document order information for MPC74x7RXnnnnNx series part number specification.

Table 26. Document Revision History (continued)

Revision Number	Date	Substantive Change(s)
4		Table 9: Corrected pin lists for input and output AC timing to correctly show $\overline{\text{HIT}}$ as an output-only signal
		Added specifications for 1267 MHz devices; removed specs for 1300 MHz devices.
		Section 5.2.3: Changed recommendations regarding use of L3 clock jitter in AC timing analysis. The L3 jitter is now fully comprehended in the AC timing specs and does not need to be included in the timing analysis.
3		Corrected numerous errors in lists of pins associated with t_{KHOV}, t_{KHOX}, t_{IVKH}, and t_{IXKH} in Table 9.
		Added support for 1.5 V L3 interface voltage; issues fixed in Rev. 1.1.
		Corrected typos in Table 12.
		Added data to Table 2.
		Clarified address bus pull-up resistor recommendations in Section 1.9.6.
		Modified Table 9, Figure 5, and Figure 6 to more accurately show when the mode select inputs ($\overline{\text{BMODE}}$[0:1], L3VSEL, BVSEL) are sampled and AC timing requirements
		Table 10: Added skew and jitter values.
		Table 14: Added AC timing values.
		Table 24: Updated to reflect past and current part numbers not fully covered by this document.
		Table 6: Removed CV_{IH} and CV_{IL}; V_{IH} and V_{IL} for SYSCLK input is the same as for other input signals, and is now noted accordingly in this table.
		Table 7: Removed Doze mode power entry (but left footnote 4 for clarity); documentation change only.
		Nontechnical formatting
2		Added substrate capacitor information in Sections 1.8.3 and 1.8.6.
		Increased minimum processor and VCO frequencies in Table 8 from 500 and 1000 MHz to 600 and 1200 MHz (respectively).
		Corrected maximum processor frequency for 1300 MHz devices in Table 8 (changed from 1333 to 1300 MHz).
		Added value for to $t_{L3CSKW1}$ Table 10.
		Added L3OHCR information in Section 1.5.2.4.1.
		Added values for t_{CO} and t_{ECI} to Table 11.
		Added Note 8 to Table 13 and Note 6 to Table 14.
		Changed resistor value in PLL filter in Figure 25 from 10 Ω to 400 Ω.
		Added 867 MHz speed grade.
		Corrected Product Code in Tables 22 and 23.
		Added pull-up/pull-down recommendations for $\overline{\text{CKSTP\_IN}}$ and PLL_CFG[0:4] to Section 1.9.6.
1.1		Nontechnical reformatting.

Table 26. Document Revision History (continued)

Revision Number	Date	Substantive Change(s)
1		Removed support for 1.5 V L3 interface voltage from Tables 3 and 4. 1.5 V I/O voltage is not supported in current MPC7457 devices.
		Added package thermal characteristics values to Table 5, made minor revisions to Section 1.9.8.
		Added preliminary AC timing values to Tables 10 and 12.
		Added footnotes to Table 17.
0		Initial release.

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